

## Abstract

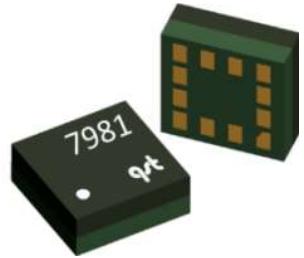
### Single-Chip 3-Axis Accelerometer

#### QMA7981

Advanced Information

The QMA7981 is a single chip three-axis accelerometer. This surface-mount, small sized chip has integrated acceleration transducer with signal conditioning ASIC, sensing tilt, motion, shock and vibration, targeted for applications such as screen rotation, step counting, sleep quality, gaming and personal navigation in mobile and wearable smart devices.

The QMA7981 is based on our state-of-the-art, high resolution single crystal silicon MEMS technology. Along with custom-designed 14-bit ADC ASIC, it offers the advantages of low noise, high accuracy, low power consumption, and offset trimming. The device supports digital interface I<sup>2</sup>C and SPI.



The QMA7981 is in a 2x2x0.95mm<sup>3</sup> surface mount 12-pin land grid array (LGA) package.

## FEATURES

- ▶ 3-Axis Accelerometer in a 2x2x0.95 mm<sup>3</sup> Land Grid Array Package (LGA), guaranteed to operate over a temperature range of -40 °C to +85 °C.
- ▶ 14-Bit ADC with low noise accelerometer sensor
- ▶ I<sup>2</sup>C Interface with Standard and Fast modes. Support SPI digital interface
- ▶ Built-In Self-Test
- ▶ Wide range operation voltage (1.71V To 3.6V) and low power consumption (2-50uA low power conversion current)
- ▶ RoHS compliant , halogen-free
- ▶ Built-in motion algorithm

## BENEFIT

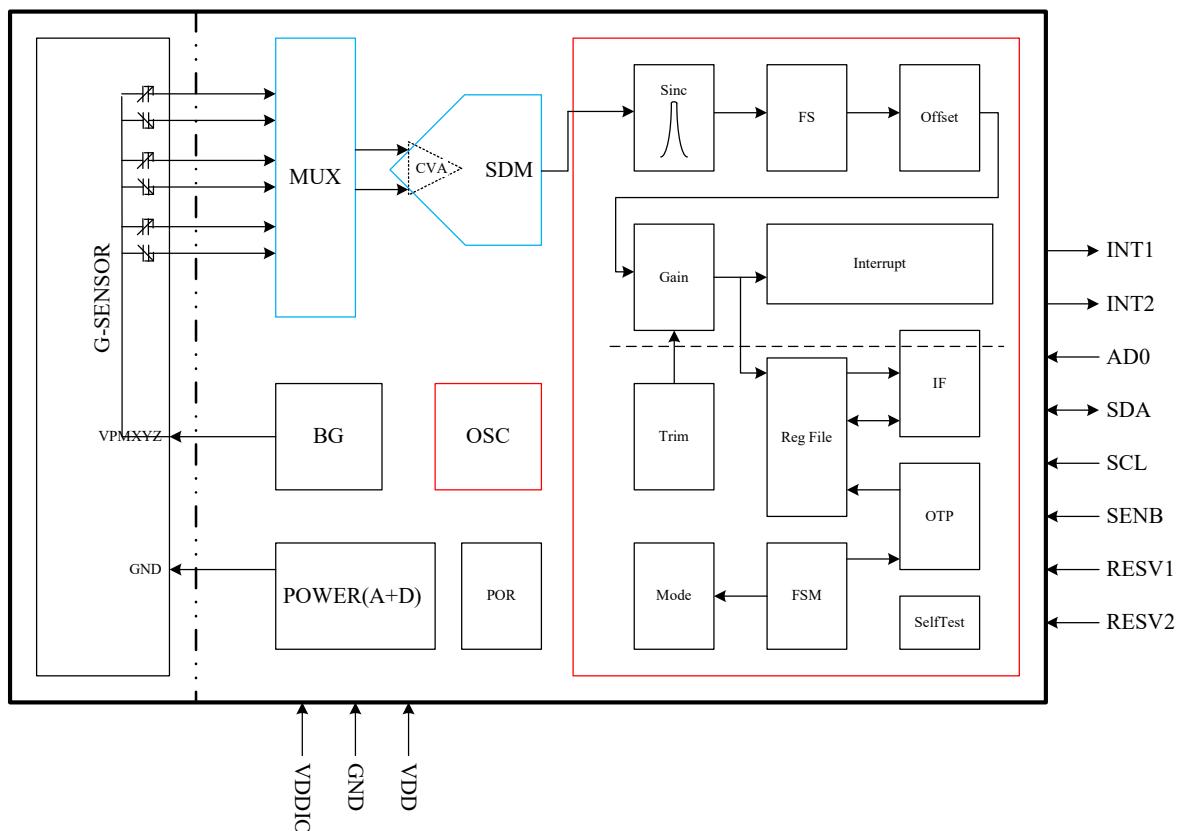
- ▶ Small size for highly integrated products. Signals have been digitized and factory trimmed.
- ▶ High resolution allows for motion and tilt sensing
- ▶ High-Speed Interfaces for fast data communications.
- ▶ Enables low-cost functionality test after assembly in production
- ▶ Automatically maintains sensor's sensitivity under wide operation voltage range and compatible with battery powered applications
- ▶ Environmental protection and wide applications
- ▶ Low power and easy applications including step counting, sleep quality, gaming and personal navigation

## CONTENTS

CONTENTS.....	3
1 INTERNAL SCHEMATIC DIAGRAM.....	4
1.1 Internal Schematic Diagram .....	4
2 SPECIFICATIONS AND I/O CHARACTERISTICS.....	5
2.1 Product Specifications .....	5
2.2 Absolute Maximum Ratings .....	6
2.3 I/O Characteristics .....	6
3 PACKAGE PIN CONFIGURATIONS.....	6
3.1 Package 3-D View .....	6
3.2 Package Outlines .....	7
4 EXTERNAL CONNECTION.....	10
4.1 I2C Dual Supply Connection.....	10
4.2 I2C Single Supply connection .....	10
4.3 SPI Dual Supply Connection.....	11
4.4 SPI Single Supply connection .....	11
5 BASIC DEVICE OPERATION.....	12
5.1 Acceleration sensor.....	12
5.2 Power Management.....	12
5.3 Power On/Off Time.....	12
5.4 Communication Bus Interface I <sup>2</sup> C and Its Addresses.....	13
6 MODES OF OPERATION .....	14
6.1 Modes Transition.....	14
6.2 Description of Modes .....	15
7 Functions and interrupts .....	15
7.1 STEP_INT .....	15
7.2 DRDY_INT .....	16
7.3 ANY_MOT_INT .....	16
7.4 SIG_MOT_INT .....	17
7.5 NO_MOT_INT .....	17
7.6 RAISE_INT .....	17
7.7 Interrupt configuration.....	18
8 I <sup>2</sup> C COMMUNICATION PROTOCOL.....	19
8.1 I <sup>2</sup> C Timings .....	19
8.2 I <sup>2</sup> C R/W Operation .....	19
9 REGISTERS .....	21
9.1 Register Map .....	21
9.2 Register Definition .....	22

## 1 INTERNAL SCHEMATIC DIAGRAM

### 1.1 Internal Schematic Diagram



**Figure 1. Block Diagram**

**Table 1. Block Function**

Block	Function
Transducer	3-axis acceleration sensor
CVA	Charge-to-Voltage amplifier for sensor signals
Interrupt	Digital interrupt engine, to generate interrupt signal on data conversion, and motion function
FSM	Finite state machine, to control device in different mode
I <sup>2</sup> C/SPI	Interface logic data I/O
OSC	Internal oscillator for internal operation
Power	Power block, including LDO

## 2 SPECIFICATIONS AND I/O CHARACTERISTICS

### 2.1 Product Specifications

Table 2. Specifications (\* Tested and specified at 25°C and 3.0V VDD except stated otherwise.)

Parameter	Conditions	Min	Typ	Max	Unit
Supply voltage VDD	VDD, for internal blocks	1.71	3.3	3.6	V
I/O voltage VDDIO	VDDIO, for IO only	1.71	3.3	VDD	V
Standby current	VDD and VDDIO on		1		µA
Low power current	ODR=268 Hz		50		µA
	ODR=134 Hz		25.3		
	ODR=67 Hz		12.9		
	ODR=33.6 Hz		6.7		
	ODR=13.4 Hz		2.9		
	ODR=6.7 Hz		1.7		
Low noise current	ODR=32.5 Hz		100		µA
	ODR=21.6 Hz		83.3		
	ODR=13 Hz		50		
	ODR=6.5 Hz		25		
BW	Programmable bandwidth		0.16~168		Hz
Data output rate (ODR)	2*BW		0.32~336		Samples /sec
Startup time	From the time when VDD reaches to 90% of final value to the time when device is ready for conversion		2		ms
Wakeup time	From the time device enters into active mode to the time device is ready for conversion		1		ms
Operating temperature		-40		85	°C
Acceleration Full Range			±2/±4/±8/ ±16/±32		g
Sensitivity	FS=±2g		4096		LSB/g
	FS=±4g		2048		
	FS=±8g		1024		
	FS=±16g		512		
	FS=±32g		256		
Sensitivity Temperature Drift	FS=±2g, Normal VDD Supplies		±0.02		%/°C
Sensitivity tolerance	Gain accuracy		±4		%
Zero-g offset	FS=±2g, Normal VDD Supplies		±80		mg
Zero-g offset Temperature Drift	FS=±2g, Normal VDD Supplies		±2		mg/°C
Noise density	FS=±2g, run state		200		µg/ √ Hz
Nonlinearity	FS=±2g, Best fit straight line,		±0.5		%FS
Cross Axis Sensitivity			1		%

## 2.2 Absolute Maximum Ratings

**Table 3. Absolute Maximum Ratings (Tested at 25°C except stated otherwise.)**

Parameters	Condition	Min	Max	Units
VDD		-0.3	5.4	V
VDDIO		-0.3	5.4	V
ESD	HBM		2	kV
Shock Immunity	Duration < 200μS		10000	g
Storage temperature		-50	150	°C

## 2.3 I/O Characteristics

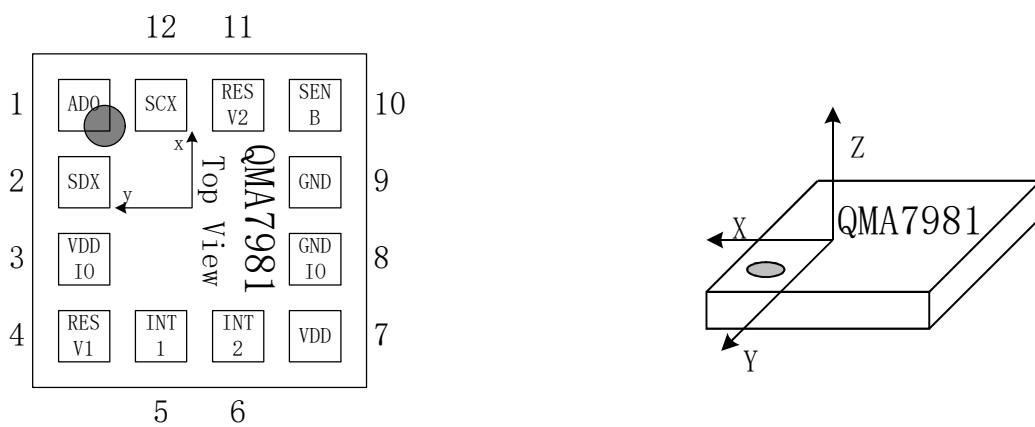
**Table 4. I/O Characteristics**

Parameter	Symbol	Pin	Condition	Min.	TYP.	Max.	Unit
Voltage Input High Level 1	$V_{IH1}$	SDA, SCL		0.7*VDDI O		$VDDIO+0 .3$	V
Voltage Input Low Level 1	$V_{IL1}$	SDA, SCL		-0.3		$0.3*VDDI O$	V
Voltage Output High Level	$V_{OH}$	INT1, INT2	Output Current $\geq -100\mu A$	0.8*VDDI O			V
Voltage Output Low Level	$V_{OL}$	INT1, INT2, SDA	Output Current $\leq 100\mu A$ (INT) Output Current $\leq 1mA$ (SDA)			$0.2*VDDI O$	V

## 3 PACKAGE PIN CONFIGURATIONS

### 3.1 Package 3-D View

Arrow indicates direction of g field that generates a positive output reading in normal measurement configuration.



**Figure 2. Package View**

Table 5. Pin Configurations

PIN No.	PIN NAME	I/O	Power Supply	TYPE	Function
1	AD0	I	VDDIO	CMOS	LSB of I <sup>2</sup> C address, or SDO of 4W SPI
2	SDX	IO	VDDIO	CMOS	Serial data for I <sup>2</sup> C, or SDI of 4W SPI, or SDIO of 3W SPI
3	VDDIO	P	VDDIO	Power	Power supply to digital interface
4	RESV1	I	VDDIO	CMOS	Reserved. Float or connect to GND
5	INT1	O	VDDIO	CMOS	Interrupt 1
6	INT2	O	VDDIO	CMOS	Interrupt 2
7	VDD	P	VDD	Power	Power supply to internal block
8	GNDIO	G	GND	Power	Ground to digital interface
9	GND	G	GND	Power	Ground to internal block
10	SENB	IO	VDDIO	CMOS	Protocol selection
11	RESV2	IO	VDDIO	CMOS	Reserved. Float, or connect to GND
12	SCL	I	VDDIO	CMOS	Serial clock for I <sup>2</sup> C, or Serial clock for SPI

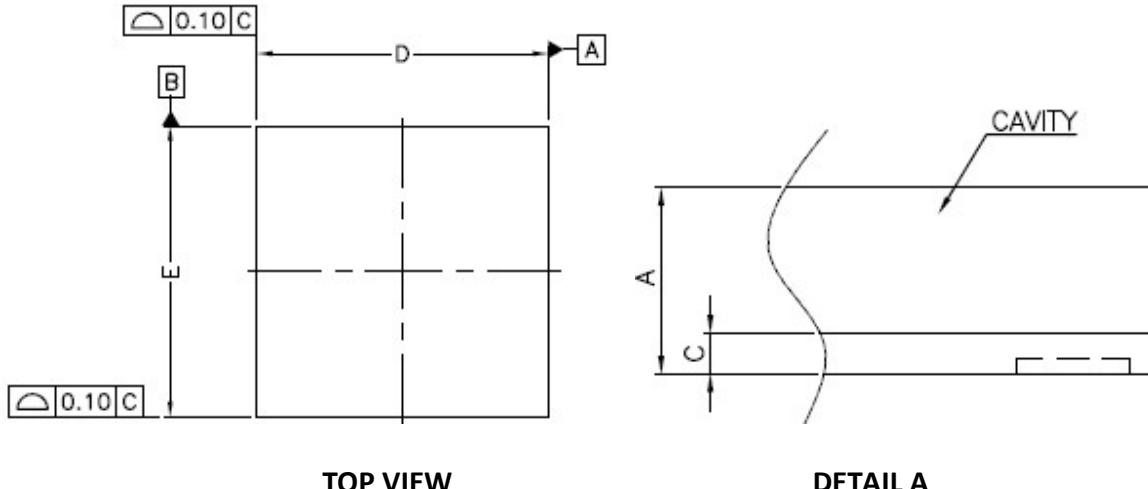
### 3.2 Package Outlines

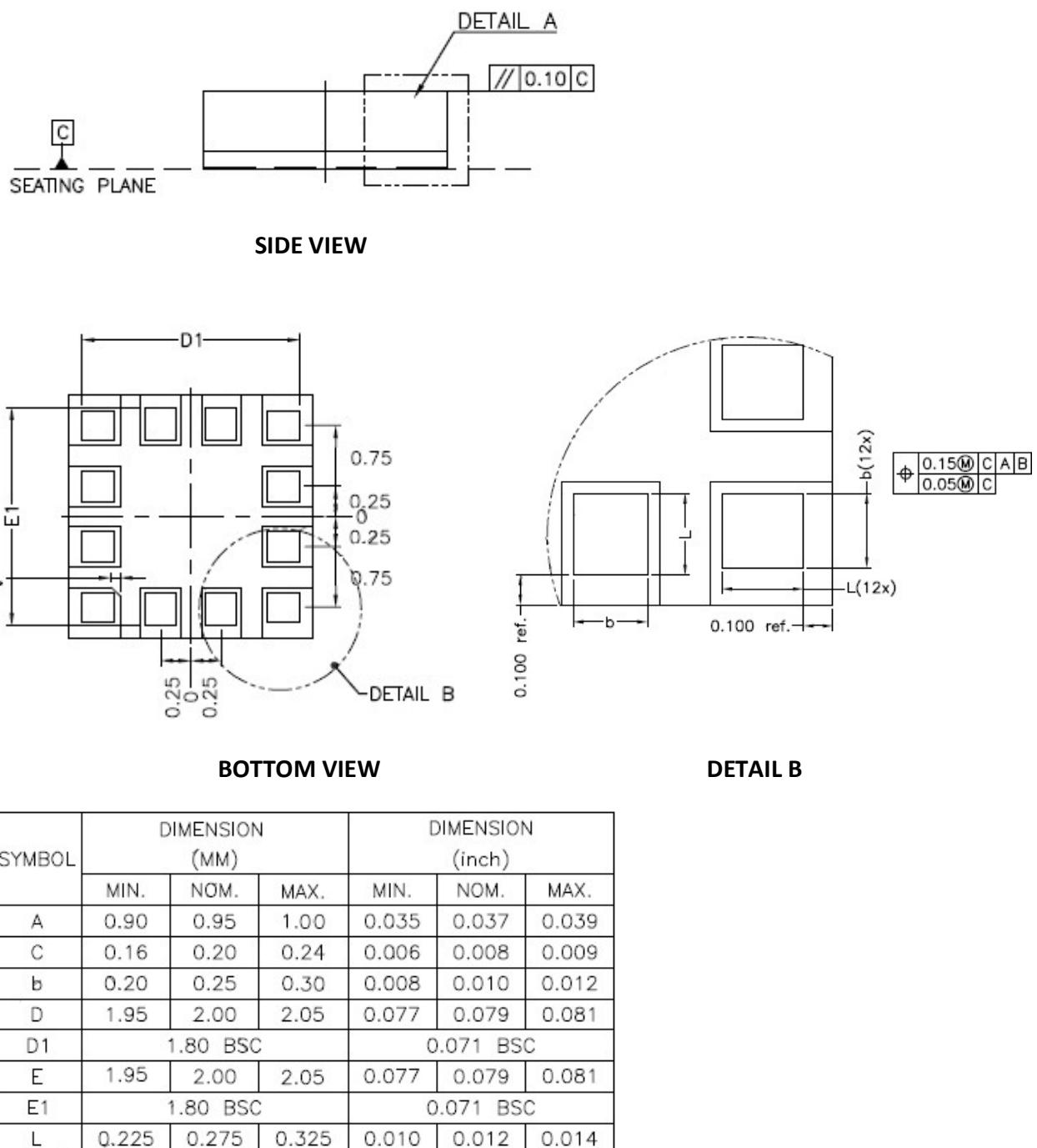
#### 3.2.1 Package Type

LGA (Land Grid Array)

#### 3.2.2 Package Outline Drawing:

2.0mm (Length)\*2.0mm (Width)\*0.95mm (Height)





## NOTE:

- CONTROLLING DIMENSION: MILLIMETER.

**Figure 3. Package Outline Drawing**

## 3.2.3 Marking:



Figure 4. Marking Format

Marking Text	Description	Comments
Line 1	Product Name	"7981" stand for QMA7981
Line 2	Y: the last digital of year CCC: lot code	Lot code: 3 alphanumeric digits, variable to generate mass production trace-code
Line 3	P: Part number S: Sub-con ID	P: 1 alphanumeric digit, variable to identify part number S: 1 alphanumeric digit, variable identify sub-con
●	Pin 1 identifier	--

## 4 EXTERNAL CONNECTION

### 4.1 I2C Dual Supply Connection

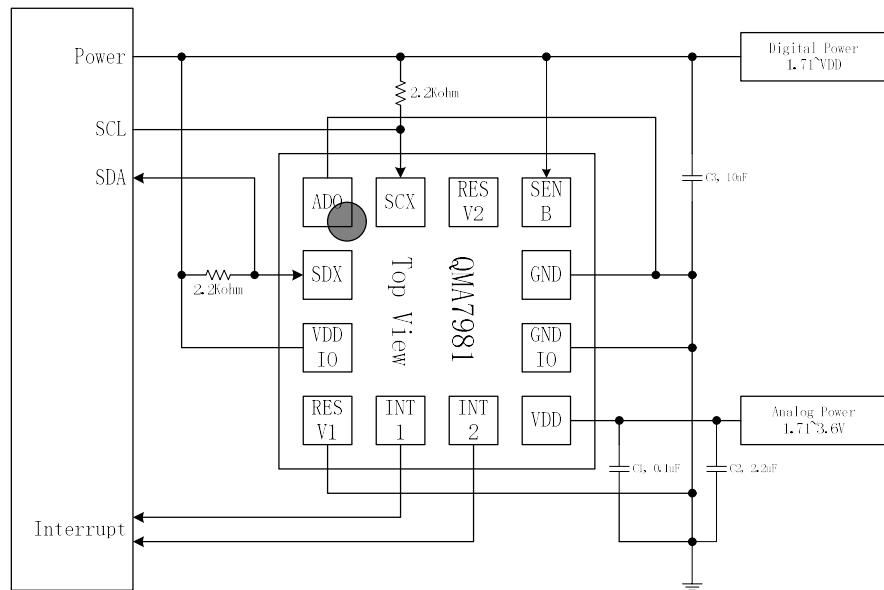


Figure 5. I2C Dual Supply Connection

### 4.2 I2C Single Supply connection

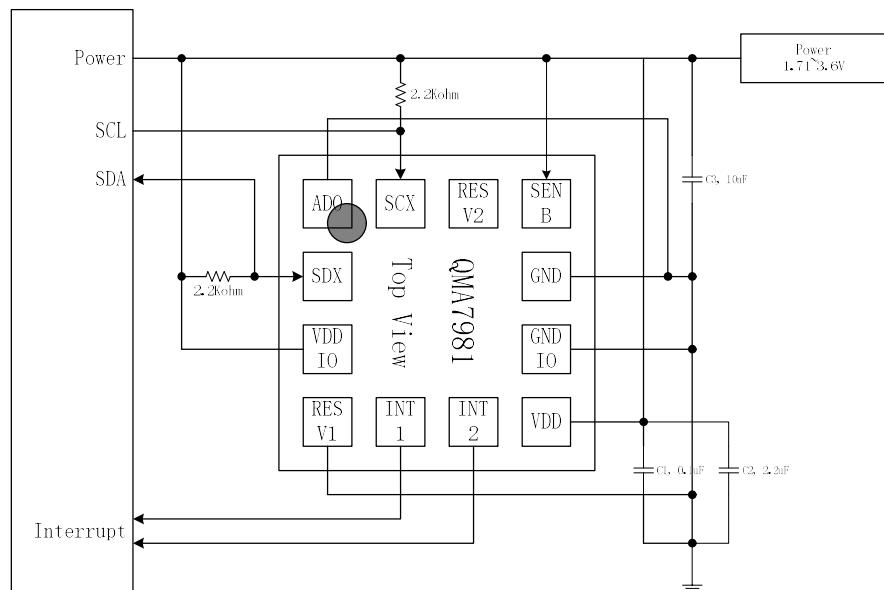


Figure 6. I2C Single Supply Connection

#### 4.3 SPI Dual Supply Connection

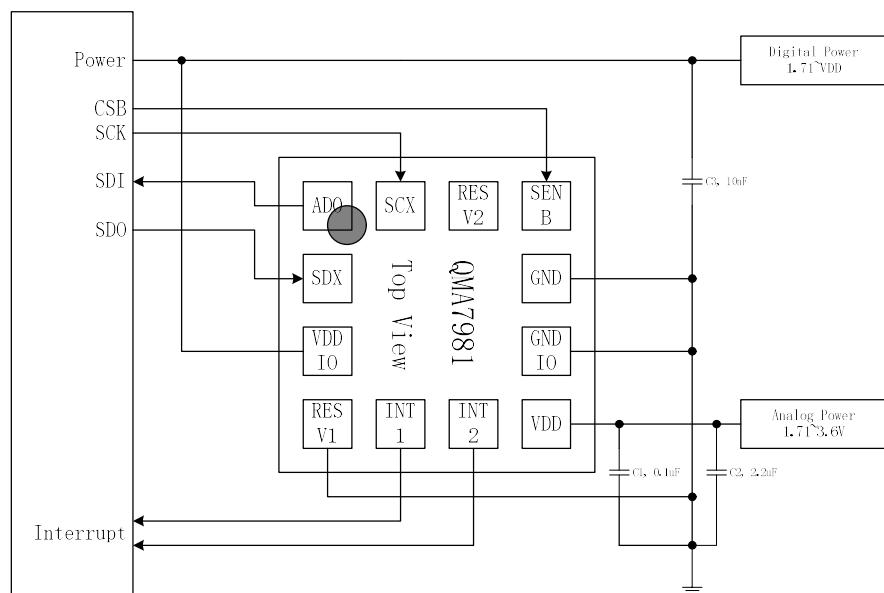


Figure 7. SPI Dual Supply Connection

#### 4.4 SPI Single Supply connection

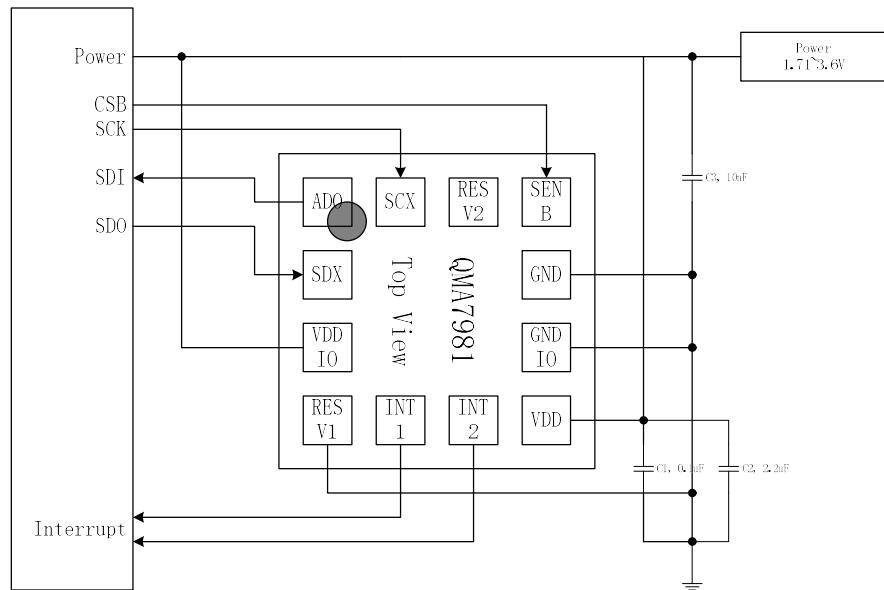


Figure 8. SPI Single Supply Connection

## 5 BASIC DEVICE OPERATION

### 5.1 Acceleration sensor

The QMA7981 acceleration sensor circuit consists of tri-axial sensors and application specific support circuits to measure the acceleration of device. When a DC power supply is applied to the sensor, the sensor converts any accelerating incident in the sensitive axis directions to charge output.

### 5.2 Power Management

Device has two power supply pins. VDD is the main power supply for all of the internal blocks, including analog and digital. VDDIO is a separate power supply, for digital interface only.

The device contains a power-on-reset generator. It generates reset pulse as power on, which can load the register's default value, for the device to function properly.

To make sure the POR block functions well, we should have such constrains on the timing of VDD and VDDIO.

The device should turn-on both power pins in order to operate properly. When the device is powered on, all registers are reset by POR, then the device transits to the standby mode and waits for further commands.

Table 6 provides references for four power states.

**Table 6. Power States**

Power State	VDD	VDDIO	Power State description
1	0V	0V	Device Off, No Power Consumption
2	0V	1.71v~3.6v	Not allowed. User need to make sure that VDDIO is less than VDD. Otherwise, there will be leakage from VDDIO to VDD through internal ESD devices
3	1.71v~3.6v	0V	Device Off, Same Current as Standby Mode
4	1.71v~3.6v	1.71v~VDD	Device On, Normal Operation Mode, Enters Standby Mode after POR

### 5.3 Power On/Off Time

Device has two power supply pins and two ground pins. VDD is the main power supply for all of the internal blocks, including analog and digital. VDDIO is a separate power supply, for digital interface only. GND is 0V supply for all of internal blocks, and GNDIO for digital interface.

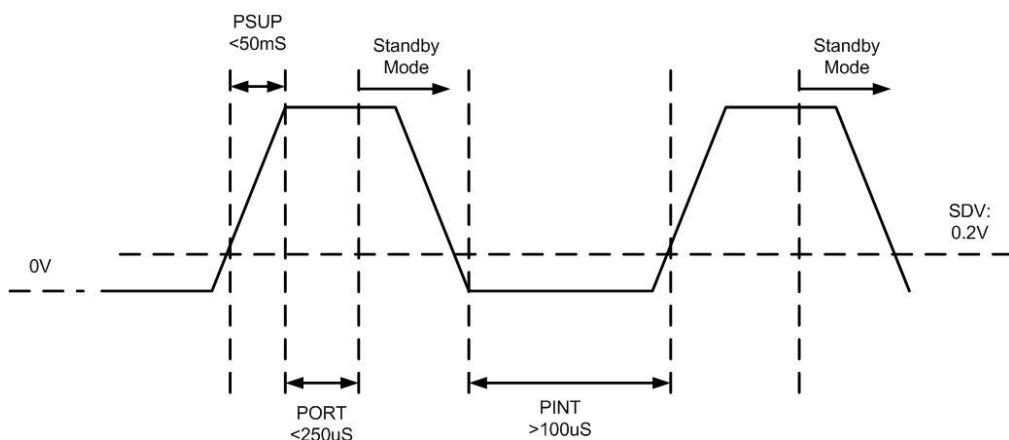
There is no limitation on the voltage levels of VDD and VDDIO relative to each other, as long as they are within operating range.

The device contains a power-on-reset generator. It generates reset pulse as power on, which can load the register's default value, for the device to function properly.

To make sure the POR block functions well, we should have such constrains on the timing of VDD. The power on/off time related to the device is in Table 7

**Table 7. Time Required for Power On/Off**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
POR Completion Time	PORT	Time Period After VDD and VDDIO at Operating Voltage to Ready for I <sup>2</sup> C Command and Analogy Measurement.			250	μs
Power off Voltage	SDV	Voltage that Device Considers to be Power Down.			0.2	V
Power on Interval	PINT	Time Period Required for Voltage Lower Than SDV to Enable Next POR	100			μs
Power on Time	PSUP	Time Period Required for Voltage from SDV to 90% of final value			50	ms



**Power On/Off Timing**

**Figure 9. Power On/Off Timing**

## 5.4

### Communication Bus Interface I<sup>2</sup>C and Its Addresses

This device will be connected to a serial interface bus as a slave device under the control of a master device, such as the processor. Control of this device is carried out via I<sup>2</sup>C.

This device is compliant with I<sup>2</sup>C -Bus Specification, document number: 9398 393 40011. As an I<sup>2</sup>C compatible device, this device has a 7-bit serial address and supports I<sup>2</sup>C protocols. This device supports standard and fast speed modes, 100 kHz and 400 kHz, respectively. External pull-up resistors are required to support all these modes.

There are two I<sup>2</sup>C addresses selected by connecting pin 1 (A0) to GND or VDDIO. The first six MSB are hardware configured to "001001" and the LSB can be configured by A0.

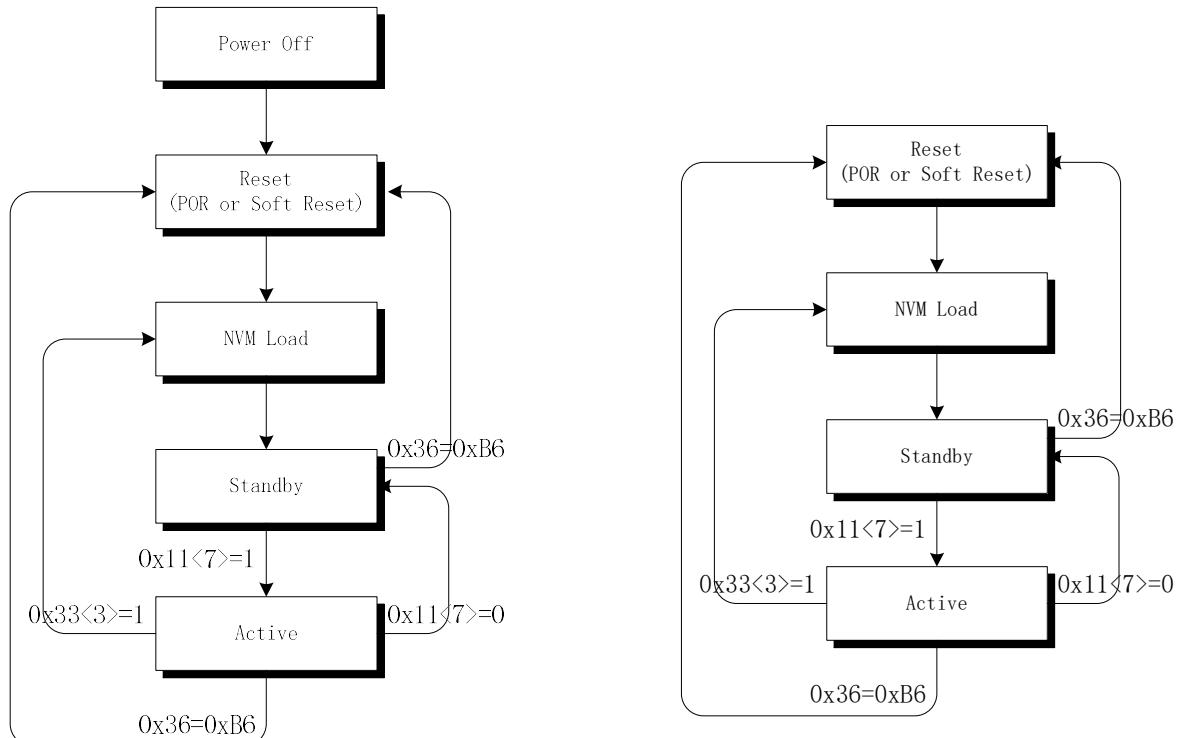
**Table 8. I<sup>2</sup>C Address Options**

AD0 (pin 1)	I <sup>2</sup> C Slave Address(HEX)	I <sup>2</sup> C Slave Address(BIN)
Connect to GND	12	0010010
Connect to VDDIO	13	0010011

## 6 MODES OF OPERATION

### 6.1 Modes Transition

QMA7981 has two different operational modes, controlled by register (0x11), MODE\_BIT. The main purpose of these modes is for power management. The modes can be transited from one to another, as shown below, through I<sup>2</sup>C commands. The default mode after power-on is standby mode.

**Figure 10. Basic operation flow after power-on****Figure 11. The work mode transferring**

The default mode after power on is standby mode. Through I<sup>2</sup>C instruction, device can switch between standby mode and active mode. With SOFTRESET by writing 0xB6 into register 0x36, all of the registers will get default values. SOFTRESET can be done both in active mode and in standby mode. Also, by writing 1 in NVM\_LOAD (0x33<3>) when device is in active mode, the NVM related image registers will get default value from NVM, however, other registers will keep the values of their own.

## 6.2 Description of Modes

### 6.2.1 Active Mode

In active mode, the ADC digitizes the charge signals from transducer, and digital signal processor conditions these signals in digital domain, processes the interrupts, and send data to Data registers (0x01~0x06).

### 6.2.2 Standby Mode

In standby mode, most of the blocks are off, while device is ready for access through I<sup>2</sup>C. Standby mode is the default mode after power on or soft reset. Device can enter into this mode by set the soft reset register (0x36) to 0xB6 or set the MODE\_BIT (0x11<7>) to logic 0.

Besides the above two modes, the device also contains NVM loading state. This state is used to reset the value of the NVM related image registers. There are two bits related to this state. When NVM\_LOAD (0x33<3>) is set to 1, NVM loading starts. When the device is in NVM loading state, NVM\_RDY (0x33<2>) is set to logic 0 by device. After NVM loading is finished, NVM\_RDY (0x33<2>) is set back to logic 1 by device, and NVM\_LOAD is reset to 0 by device automatically. NVM loading can only happen when NVM\_LOAD is set to 1 in active mode. If the user sets this NVM\_LOAD bit to 1 in standby mode, the device will not take the action until it enters into active state by setting MODE\_BIT (0x11<7>) to logic 1.

After loading NVM, the device will enter into standby mode directly.

The loading time for NVM is about 100uS.

## 7 Functions and interrupts

ASIC support interrupts, such as STEP\_INT, DRDY\_INT, ANY\_MOT\_INT, SIG\_MOT\_INT, NO\_MOT\_INT, RAISE\_INT, etc.

### 7.1 STEP\_INT

The STEP/STEP\_QUIT detect that the user is entering/exiting step mode. When the user enter into step mode, at least one axis sensor data will vary periodically, by numbering the variation periods the step counter can be calculated.

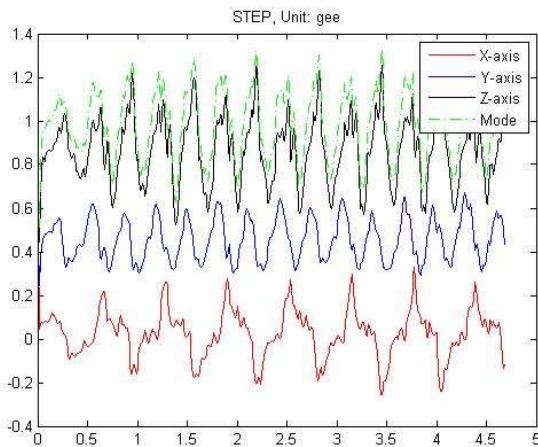


Figure 10. STEP/STEP\_QUIT

Median data (max+min) /2 is called dynamic threshold, the max and min data can be updated by certainly samples, the sample number can be set by register STEP\_SAMPLE\_CNT (0x12<6:0>). When the sensor data decreasing (or increasing) through the dynamic threshold, a user run step is detected.

Register STEP\_PRECISION (0x13<6:0>) is used as threshold when updating the new collected sensor data. Sensor data below the threshold will be discarded, this helps removing unstable variations causing failed detection.

The run step event happened at certain interval timing. All of the events outside the timing window will not be regarded as a run step and the step counter will not be counted. The timing window can be set by register STEP\_TIME\_UP(0x15) and STEP\_TIME\_LOW(0x14), the conversion ODR numbers ranged from STEP\_TIME\_LOW \*ODR to 8\*STEP\_TIME\_UP\*ODR.

STEP\_COUNT\_PEAK<2:0> is used to set a fixed peak value for step detection, 0.05G~0.4G can be set. STEP\_COUNT\_P2P<2:0> is used to set a peak to peak threshold for step detection, 0.3G~1G can be set.

To remove unstable variation which will cause false STEP event detection, the step counter considers steps as valid step events only after some continuous steps detected; the start threshold can be set by 0x1F<7:5>. Also, the step counter register STEP\_CNT<23:0> ({0x0E,0x08,0x07}) will be updated immediately by the setting number, and interrupt STEP is also generated.

The related interrupt status bit is STEP\_INT (0x0A<3>) and SIG\_STEP (0x0A<6>). When the interrupt is generated, the value of STEP\_INT will be set to logic 1, which will be cleared after the interrupt status register is read by user.

STEP\_IEN/SIG\_STEP\_IEN (0x16<3>/0x16<6>) is the enable bit for the STEP\_INT/SIG\_STEP\_INT. Also, to get this interrupt on PIN\_INT1 and/or PIN\_INT2, we need to set INT1\_STEP (0x19<3>)/INT1\_SIG\_STEP (0x19<6>) or INT2\_STEP (0x1B<3>)/INT2\_SIG\_STEP (0x1B<6>) to logic 1, to map the internal interrupt to the interrupt PINs.

## 7.2 DRDY\_INT

The width of the acceleration data is 14 bits, in two's complement representation. The data of each axis is split into 2 parts, the MSB part (one byte contains bit 13 to bit 6) and the LSB part (one byte contains bit 5 to bit 0). Reading data should start with LSB part. When user is reading the LSB byte of data, to ensure the integrity of the acceleration data, the content of MSB can be locked, by setting SHADOW\_DIS (0x21<6>) to logic 0. This lock function can be disabled by setting SHADOW\_DIS to logic 1. Without lock, the MSB and LSB content will be updated by new value immediately. The bit NEW\_DATA in the LSB byte is the flag of the new data. If new data is updated, this NEW\_DATA flag will be 1, and will be cleared when corresponding MSB or LSB is read by user.

Also, the user should note that even with SHADOW\_DIS=0, the data of 3 axes are not guaranteed from the same time point.

The device supports four different acceleration measurement ranges. The range is setting through RANGE (0x0F<3:0>), and the details as following:

RANGE	Acceleration range	Resolution
0001	2g	244ug/LSB
0010	4g	488ug/LSB
0100	8g	977ug/LSB
1000	16g	1.95mg/LSB
1111	32g	3.91mg/LSB
Others	2g	244ug/LSB

The interrupt for the new data serves for the synchronous data reading for the host. It is generated after storing a new value of z-axis acceleration data into data register. This interrupt will be cleared automatically when the next data conversion cycle starts, and the interrupt will be effective about 64\*MCLK, and automatically cleared.

The interrupt mode for the new data is fixed to be non-latched.

## 7.3 ANY\_MOT\_INT

Any motion Any motion detection uses slope between two successive data to detect the changes in motion. It generates interrupt when a preset threshold ANY\_MOT\_TH (0x2E) is exceeded.

The time difference between two successive data depends on the output data rate (ODR).

$$\text{Slope}(t1) = (acc(t1) - acc(t0)) * ODR$$

The any motion detection criteria are fulfilled and interrupt is generated if any of enabled channels exceeds ANY\_MOT\_TH for ANY\_MOT\_DUR (0x2C<1:0>) consecutive times.

As long as all the enabled channels data fall or stay below ANY\_MOT\_TH for ANY\_MOT\_DUR consecutive times, the interrupt will be reset unless the interrupt signal is latched.

The any motion detection engine will send out the signals of axis which triggered the interrupt (ANY\_MOT\_FIRST\_X (0x09<0>), ANY\_MOT\_FIRST\_Y (0x09<1>), ANY\_MOT\_FIRST\_Z (0x09<2>)) and the sign of the motion (ANY\_MOT\_SIGN (0x09<3>))

## 7.4 SIG\_MOT\_INT

A significant motion is a motion due to a change in user location.

The algorithm is as following:

- 1) Look for movement, same setting as any motion detection
- 2) If movement detected, sleep for T\_Skip (0x2F<3:2>)
- 3) Look for movement
  - a) If no movement detected within T\_Proof (0x2F<5:4>), go back to 1
  - b) If movement detected, report a significant movement, and generate the interrupt

The significant motion detection and any motion detection are exclusive, user can select either one through SIG\_MOT\_SEL (0x2F<0>).

If significant motion is detected, the engine will set SIG\_MOT\_INT (0x0A<0>).

## 7.5 NO\_MOT\_INT

No-motion interrupt is generated if the slope (absolute value of acceleration difference) on all selected axes is smaller than the programmable threshold for a programmable time. Figure shows the timing for the no-motion interrupt. Register (0x2C) NO\_MOT\_DUR defines the delay times before the no-motion interrupt is generated. Table lists the delay times adjustable with register (0x2C) NO\_MOT\_DUR.

The no-motion interrupt is enabled per axis by writing logic 1 to bits (0x18) NO\_MOTION\_EN\_X, (0x18) NO\_MOTION\_EN\_Y, and (0x18) NO\_MOTION\_EN\_Z, respectively. The no-motion threshold is set through the (0x2D) NO\_MOT\_TH register. The meaning of an LSB of (0x2D) NO\_MOT\_TH depends on the selected g-range: it corresponds to 3.91mg in 2g-range (7.81mg in 4g-range, 15.6mg in 8g-range, 31.25mg in 16g-range, 62.5mg in 32g-range). Therefore the maximum value is 996mg in 2g-range (2g in 4g-range, 4g in 8g-range, 8g in 16g-range, and 16g in 32g-range). The time difference between the successive acceleration samples depends on the selected ODR and equates to 1/ODR.

## 7.6 RAISE\_INT

Raise wake algorithm is used to detect the action of raise hand (or hand down). The interrupt is enabled by writing logic 1 to bits (0X16[1]) RAISE\_EN, (0X16[2]) HD\_EN. User can adjust the sensitivity through the registers. The register RAISE\_WAKE\_SUM\_TH(0X2A[5:0]) defines the strength of hand action (raise and down). The register RAISE\_DIFF\_TH(0X2A[7:6],0X2B[1:0]) defines the differential values of twice actions, when the hand behavior almost done the differential value will be smaller and we can use this register to set the threshold. RAISE\_WAKE\_PERIOD and RAISE\_WAKE\_TIMEOUT\_TH define the duration of the total hand action.

## 7.7 Interrupt configuration

The device has the above 3 interrupt engines. Each of the interrupts can be enabled and configured independently. If the trigger condition of the enabled interrupt fulfilled, the corresponding interrupt status bit will be set to logic 1, and the mapped interrupt pin will be activated. The device has two interrupt PINs, INT1 and INT2. Each of the interrupts can be mapped to either PIN or both PINs.

The interrupt status registers INT\_ST(0x09~0x0d) will update when a new data word is written into the data registers. If an interrupt is disabled, the related active interrupt status bit is disabled immediately.

When interrupt condition is fulfilled, related bit of interrupt will be set, until the associated interrupt condition is no more valid. Read operation to related register will also clear the register.

Device supports 2 interrupt modes, non-latched, and latched mode. The interrupt modes are set through LATCH\_INT (0x21<0>).

In non-latched mode, the mapped interrupt pin will be set and/or cleared same as associated interrupt register bit. Also, the mapped interrupt pin can be cleared with read operation to any of the INT\_ST(0x09~0x0d).

Exception to this is the new data interrupt and step interrupt, which are automatically reset after a fixed time ( $T_{Pulse} = 64/MCLK$ ), no matter LATCH\_INT (0x21<0>) is set to 0 or 1.

In latched mode, the clearings of mapped pins are determined by INT\_RD\_CLR (0x21<7>).

If the condition for triggering the interrupt still holds, the interrupt status will be set again with the next change of the data registers.

Mapping the interrupt pins can be set by INT\_MAP (0x19~0x1B).

The electrical interrupt pins can be set INT\_PIN\_CONF (0x20<3:0>). The active logic level can be set to 1 or 0, and the interrupt pin can be set to open-drain or push-pull.

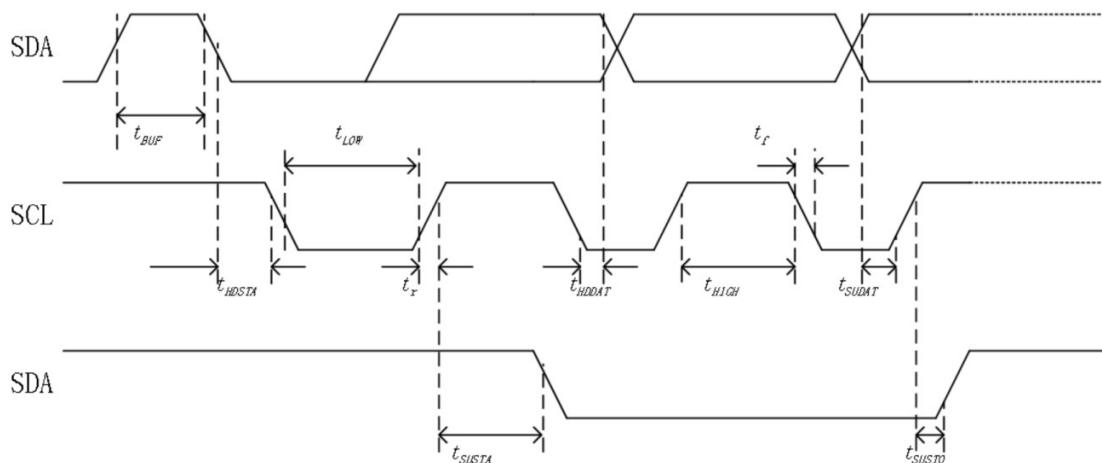
## 8 I<sup>2</sup>C COMMUNICATION PROTOCOL

### 8.1 I<sup>2</sup>C Timings

Table 9 and Figure 11 describe the I<sup>2</sup>C communication protocol times

**Table 9. I<sup>2</sup>C Timings**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
SCL Clock	$f_{scl}$		0		400	kHz
SCL Low Period	$t_{low}$		1			$\mu s$
SCL High Period	$t_{high}$		1			$\mu s$
SDA Setup Time	$t_{sudat}$		0.1			$\mu s$
SDA Hold Time	$t_{hddat}$		0		0.9	$\mu s$
Start Hold Time	$t_{hdsta}$		0.6			$\mu s$
Start Setup Time	$t_{susta}$		0.6			$\mu s$
Stop Setup Time	$t_{susto}$		0.6			$\mu s$
New Transmission Time	$t_{buf}$		1.3			$\mu s$
Rise Time	$t_r$					$\mu s$
Fall Time	$t_f$					$\mu s$



**Figure 11. I<sup>2</sup>C Timing Diagram**

### 8.2 I<sup>2</sup>C R/W Operation

#### 8.2.1 Abbreviation

**Table 10. Abbreviation**

SACK	Acknowledged by slave
MACK	Acknowledged by master
NACK	Not acknowledged by master
RW	Read/Write

### 8.2.2 Start/Stop/Ack

START: Data transmission begins with a high to transition on SDA while SCL is held high. Once I<sup>2</sup>C transmission starts, the bus is considered busy.

STOP: STOP condition is a low to high transition on SDA line while SCL is held high.

ACK: Each byte of data transferred must be acknowledged. The transmitter must release the SDA line during the acknowledge pulse while the receiver must then pull the SDA line low so that it remains stable low during the high period of the acknowledge clock cycle.

NACK: If the receiver doesn't pull down the SDA line during the high period of the acknowledge clock cycle, it's recognized as NACK by the transmitter.

### 8.2.3 I<sup>2</sup>C Write

I<sup>2</sup>C write sequence begins with start condition generated by master followed by 7 bits slave address and a write bit (R/W=0). The slave sends an acknowledge bit (ACK=0) and releases the bus. The master sends the one byte register address. The slave again acknowledges the transmission and waits for 8 bits data which shall be written to the specified register address. After the slave acknowledges the data byte, the master generates a stop signal and terminates the writing protocol.

**Table 11. I<sup>2</sup>C Write**

START	Slave Address							R W	SACK	Register Address (0x11)							SACK	Data (0x80)							SACK	STOP
	0	0	1	0	0	1	0			0	0	0	1	0	0	0		1	0	0	0	0	0	0		

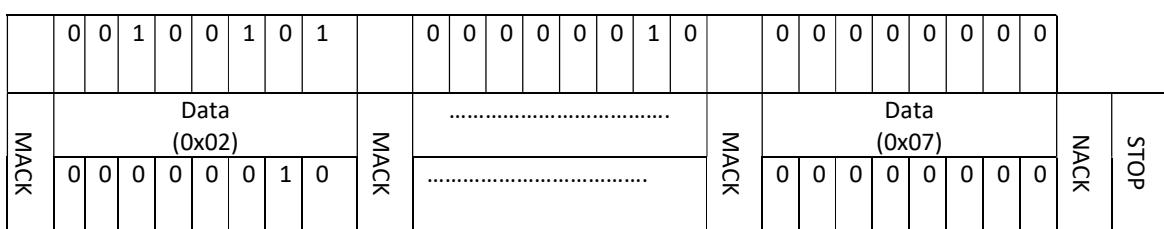
### 8.2.4 I<sup>2</sup>C Read

I<sup>2</sup>C write sequence consists of a one-byte I<sup>2</sup>C write phase followed by the I<sup>2</sup>C read phase. A start condition must be generated between two phase. The I<sup>2</sup>C write phase addresses the slave and sends the register address to be read. After slave acknowledges the transmission, the master generates again a start condition and sends the slave address together with a read bit (R/W=1). Then master releases the bus and waits for the data bytes to be read out from slave. After each data byte the master has to generate an acknowledge bit (ACK = 0) to enable further data transfer. A NACK from the master stops the data being transferred from the slave. The slave releases the bus so that the master can generate a STOP condition and terminate the transmission.

The register address is automatically incremented and more than one byte can be sequentially read out. Once a new data read transmission starts, the start address will be set to the register address specified in the current I<sup>2</sup>C write command.

**Table 12. I<sup>2</sup>C Read**

START	Slave Address							R W	SACK	Register Address (0x00)							SACK	Data (0x00)							STOP
	0	0	1	0	0	1	0			0	0	0	0	0	0	0		1	0	0	0	0	0	0	
ST	Slave Address							R W	SA	Data (0x00)							M	Data (0x01)							STOP



## 9 REGISTERS

### 9.1 Register Map

The table below provides a list of the 8-bit registers embedded in the device and their respective function and addresses

**Table 13. Register Map**

Add.	Name	bit7	bit6	bit5	bit4	bit3	bit2	bit1	bit0	R/W	DEF
0x3F										RW	02
0x3E	RAISE_CFG									RW	00
0x36	S_RESET									RW	00
0x35										RW	81
0x34										RW	9D
0x32	ST	SELFTEST_BIT					SELFTEST_SIGN		BP_AXIS_STEP<1:0>	RW	00
0x31										RW	00
0x30	RST_MOT	MO_BP_CO	STEP_BP_CO		LOW_RST_N	HIGH_RST_N	NO_MOT_RST_N	SIG_MOT_RST_N	ANY_MOT_RST_N	RW	1F
0x2F					SIG_MOT_TPROOF<1:0>		SIG_MOT_TSKIP<1:0>		SIG_MOT_SEL	RW	00
0x2E							ANY_MOT_TH<7:0>			RW	00
0x2D							NO_MOT_TH<7:0>			RW	00
0x2C	MOT_CFG				NO_MOT_DUR<5:0>				ANY_MOT_DUR<1:0>	RW	00
0x2B					HD_Z_TH[2:0]		HD_X_TH[2:0]		RAISE_WAKE_DIFF_TH[3:2]	RW	7C
0x2A	RAISE_CFG				RAISE_WAKE_DIFF_TH[1:0]		RAISE_WAKE_SUM_TH[5:0]			RW	D8
0x29							OS_CUST_Z<7:0>			RW	00
0x28							OS_CUST_Y<7:0>			RW	00
0x27	OS_CUST						OS_CUST_X<7:0>			RW	00
0x21	INT_CFG	INT_RD_CLR	SHADOW_DIS	DIS_I2C	1	1	1	LATCH_INT_STEP	LATCH_INT	RW	1C
0x20	INT_FIN_CFG	DIS_PU_SENB	DIS_IE_ADO	EN_SPI3W	STEP_COUNT_PEAK<2>	INT2_OD	INT2_LVL	INT1_OD	INT1_LVL	RW	05
0x1F					STEP_START_CNT<2:0>	STEP_COUNT_PEAK<1:0>			STEP_COUNT_P2P<2:0>	RW	A9
0x1E					Z_TH[3:0]				X_TH[3:0]	RW	66
0x1D	STEP_CFG				STEP_INTERVAL<6:0>				EN_RESET_DC	RW	00
0x1C		INT2_NO_MOT	1	1	INT2_DATA	INT2_LOW	INT2_HIGH	1	INT2_ANY_MOT	RW	62
0x1B		1	INT2_SIG_STEP	1	1	INT2_STEP	INT2_HD	INT2_RAISE	INT2_SIG_MOT	RW	B0
0x1A		INT1_NO_MOT	1	1	INT1_DATA	INT1_LOW	INT1_HIGH	1	INT1_ANY_MOT	RW	62
0x19	INT_MAP	1	INT1_SIG_STEP	1	1	INT1_STEP	INT1_HD	INT1_RAISE	INT1_SIG_MOT	RW	B0
0x18		NO_MOT_EN_Z	NO_MOT_EN_Y	NO_MOT_EN_X	1	1	ANY_MOT_EN_Z	ANY_MOT_EN_Y	ANY_MOT_EN_X	RW	18
0x17		1	1	1	INT_DATA_EN	LOW_EN	HIGH_EN_Z	HIGH_EN_Y	HIGH_EN_X	RW	E0
0x16	INT_EN	1	SIG_STEP_IEN	1	1	SIG_STEP_IEN	HD_EN	RAISE_EN	1	RW	B1
0x15						STEP_TIME_UP<7:0>				RW	19
0x14						STEP_TIME_LOW<7:0>				RW	7F
0x13		STEP_CLR				STEP_PRECISION<6:0>				RW	14
0x12	STEP_CFG	STEP_EN				STEP_SAMPLE_CNT<6:0>				RW	40
0x11	PM	MODE_BIT	1	T_RSTB_SINC_SEL<1:0>				MCLK_SEL<3:0>		RW	E0
0x10	BW	1	1	1				BW<4:0>		RW	F0
0x0F	FSR	1	1	1	1			RANGE<3:0>		RW	00
0x0E	STEPCNT					STEP_CNT<23:16>				R	00
0x0D										R	00
0x0C						HIGH_INT	HIGH_SIGN	HIGH_FIRST_Z	HIGH_FIRST_Y	R	00
0x0B						DATA_INT	LOW_INT			R	00
0x0A				SIG_STEP		STEP_INT	HD_INT	RAISE_INT	SIG_MOT_INT	R	00
0x09	INT_ST	NO_MOT				ANY_MOT_SIGN	ANY_MOT_FIRST_Z	ANY_MOT_FIRST_Y	ANY_MOT_FIRST_X	R	00
0x08						STEP_CNT<15:8>				R	00
0x07	STEPCNT					STEP_CNT<7:0>				R	00
0x06						ACC_Z<13:6>				R	00
0x05						ACC_Y<13:6>			NEWDATA_Z	R	00
0x04						ACC_Y<5:0>			NEWDATA_Y	R	00
0x03						ACC_X<13:6>			NEWDATA_X	R	00
0x02	DATA				ACC_X<5:0>				NEWDATA_X	R	00
0x00	CHIP_ID				CHIP ID to indicate the product version					R	ANA

## 9.2 Register Definition

Register 0x00 (CHIP ID)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
CHIP_ID<7:0>								RW	0xEX

This register is used to identify the device

Register 0x01 ~ 0x02 (DXL, DXM)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
DX<5:0>							NEWDATA_X	R	0x00
DX<13:6>								R	0x00

DX: 14bits acceleration data of x-channel. This data is in two's complement.

NEWDATA\_X:  
1, acceleration data of x-channel has been updated since last reading  
0, acceleration data of x-channel has not been updated since last reading

Register 0x03 ~ 0x04 (DYL, DYM)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
DY<5:0>							NEWDATA_Y	R	0x00
DY<13:6>								R	0x00

DY: 14bits acceleration data of y-channel. This data is in two's complement.

NEWDATA\_Y:  
1, acceleration data of y-channel has been updated since last reading  
0, acceleration data of y-channel has not been updated since last reading

Register 0x05 ~ 0x06 (DZL, DZM)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
DZ<5:0>							NEWDATA_Z	R	0x00
DZ<13:6>								R	0x00

DZ: 14bits acceleration data of z-channel. This data is in two's complement.

NEWDATA\_Z:  
1, acceleration data of z-channel has been updated since last reading  
0, acceleration data of z-channel has not been updated since last reading

Register 0x07 ~ 0x08 (STEP\_CNT)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
STEP_CNT<7:0>								R	0x00
STEP_CNT<15:8>								R	0x00

STEP\_CNT<15:0> 16 bits of step counter, out of total 24bits data. The MSB data are in 0x0e

Register 0x09 (INT\_ST0)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
NO_MOT	SIG_STEP			ANY_MOT_SIGN	ANY_MOT_FIRST_Z	ANY_MOT_FIRST_Y	ANY_MOT_FIRST_X	R	0x00

NO\_MOT:

1, no\_motion interrupt active

0, no\_motion interrupt inactive

ANY\_MOT\_SIGN:

1, sign of any\_motion triggering signal is negative

0, sign of any\_motion triggering signal is positive

ANY\_MOT\_FIRST\_Z:

1, any\_motion interrupt is triggered by Z axis

0, any\_motion interrupt is not triggered by Z axis

ANY\_MOT\_FIRST\_Y:

1, any\_motion interrupt is triggered by Y axis

0, any\_motion interrupt is not triggered by Y axis

ANY\_MOT\_FIRST\_X:

1, any\_motion interrupt is triggered by X axis

0, any\_motion interrupt is not triggered by X axis

Register 0x0a (INT\_ST1)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
	SIG_STEP			STEP_INT	HD_INT	RAISE_INT	SIG_MOT_IN	R	0x00

**SIG\_STEP:** 1, significant step is active  
 0, significant step is inactive  
**STEP\_INT:** 1, step valid interrupt is active  
 0, step quit interrupt is inactive  
**HD\_INT:** 1, hand down interrupt is active  
 0, hand down interrupt is inactive  
**RAISE\_INT:** 1, raise hand interrupt is active  
 0, raise hand interrupt is inactive  
**SIG\_MOT\_INT:** 1, significant interrupt is active  
 0, significant interrupt is inactive

## Register 0x0b (INT\_ST2)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
				DATA_INT				R	0x00

**DATA\_INT:** 1, data ready interrupt active  
 0, data ready interrupt inactive

## Register 0x0e (STEP\_CNT)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
				STEP_CNT<23:16>				R	0x00

STEP\_CNT<23:16>: 8bit MSB data of step counter, out of total 24bits data. The LSB data are in 0x07 and 0x08

## Register 0x0f (FSR)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
1	1	1		RANGE<3:0>				RW	0xF0

**RANGE<3:0>:** set the full scale of the accelerometer. Setting as following

RANGE<3:0>	Acceleration range	Resolution
0001	2g	244ug/LSB
0010	4g	488g/LSB
0100	8g	977ug/LSB
1000	16g	1.95mg/LSB
1111	32g	3.91mg/LSB
Others	2g	244ug/LSB

## Register 0x10 (BW)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
1	1	1	BW<4:0>					RW	0xE0

**BW<4:0>:** bandwidth setting, as following

BW<4:0>	ODR
xx000	MCLK/7695
xx001	MCLK/3855
xx010	MCLK/1935
xx011	MCLK/975
xx100	
xx101	MCLK/15375
xx110	MCLK/30735
xx111	MCLK/61455
Others	MCLK/7695

## Register 0x11 (PM)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
MODE_BIT	1	T_RSTB_SINC_SEL<1:0>	MCLK_SEL<3:0>					RW	0x40

**MODE\_BIT:** 1, set device into active mode  
 0, set device into standby mode

**T\_RSTB\_SINC\_SEL<1:0>:** Reset clock setting. The preset time is reserved for CIC filter in digital

- 11, T\_RSTB\_SINC=8\*MCLK
- 10, T\_RSTB\_SINC=6\*MCLK
- 01, T\_RSTB\_SINC=4\*MCLK

00, T\_RSTB\_SINC=3\*MCLK

MCLK\_SEL&lt;3:0&gt;: set the master clock to digital

MCLK_SEL<3:0>	Freq of MCLK
0000	500KHz
0001	333KHz
0010	200KHz
0011	100KHz
0100	50KHz
0101	25KHz
0110	12.5KHz
0111	5KHz
1xxx	Reserved

## Register 0x12 (STEP\_CONF0)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
STEP_EN	STEP_SAMPLE_CNT<6:0>							RW	0x14

STEP\_EN: enable step counter, this bit should be set when using step counter

STEP\_SAMPLE\_CNT:

sample count setting for dynamic threshold calculation. The actual value is STEP\_SAMPLE\_CNT&lt;6:0&gt;\*8, default is 0xC, 96 sample count

## Register 0x13 (STEP\_CONF1)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
STEP_CLR	STEP_PRECISION<6:0>							RW	0x7F

STEP\_CLR: clear step count in register 0x07,0x08 and 0x0E

STEP\_PRECISION&lt;6:0&gt;:

threshold for acceleration change of two successive sample which is used to update sample\_new register in step counter, the actual g value is STEP\_PRECISION&lt;6:0&gt;\*LSB\*16 when STEP\_PRECISION&lt;6:0&gt;!&gt;0000000 &amp; !=1111111

When STEP\_PRECISION&lt;6:0&gt;=0000000, always use P2P/8

When STEP\_PRECISION&lt;6:0&gt;=1111111, always use P2P/16

When STEP\_PRECISION&lt;6:0&gt;=?, always use P2P/4

## Register 0x14 (STEP\_CONF2)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
STEP_TIME_LOW<7:0>								RW	0x19

STEP\_TIME\_LOW&lt;7:0&gt;: the short time window for a valid step, the actual time is STEP\_TIME\_LOW&lt;7:0&gt;\*(1/ODR)

## Register 0x15 (STEP\_CONF3)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
STEP_TIME_UP<7:0>								RW	0x00

STEP\_TIME\_UP&lt;7:0&gt;: time window for quitting step counter, the actual time is STEP\_TIME\_UP&lt;7:0&gt;\*8\*(1/ODR)

## Register 0x16 (INT\_EN0)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
1	SIG_STEP_I EN	1	1	STEP_IEN	HD_EN	RAISE_EN	1	RW	0xB1

SIG\_STEP\_IEN: 1, enable significant step interrupt

0, disable significant step interrupt

STEP\_IEN: 1, enable step valid interrupt

0, disable step valid interrupt

HD\_EN: 1, enable hand-down interrupt

0, disable hand-down interrupt

RAISE\_EN: 1,enable raise-hand interrupt

0,disable raise-hand interrupt

## Register 0x17 (INT\_EN1)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
1	1	1	INT_DATA _EN					RW	0xE0

INT\_DATA\_EN: 1, enable data ready interrupt

0, disable data ready interrupt

Register 0x18 (INT\_EN2)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
NO_MOT_EN_Z	NO_MOT_EN_Y	NO_MOT_EN_X	1	1	ANY_MOT_EN_Z	ANY_MOT_EN_Y	ANY_MOT_EN_X	RW	0x18

NO\_MOT\_EN\_Z: 1, enable no\_motion interrupt on Z axis  
0, disable no\_motion interrupt on Z axis  
NO\_MOT\_EN\_Y: 1, enable no\_motion interrupt on Y axis  
0, disable no\_motion interrupt on Y axis  
NO\_MOT\_EN\_X: 1, enable no\_motion interrupt on X axis  
0, disable no\_motion interrupt on X axis  
ANY\_MOT\_EN\_Z: 1, enable any\_motion interrupt on Z axis  
0, disable any\_motion interrupt on Z axis  
ANY\_MOT\_EN\_Y: 1, enable any\_motion interrupt on Y axis  
0, disable any\_motion interrupt on Y axis  
ANY\_MOT\_EN\_X: 1, enable any\_motion interrupt on X axis  
0, disable any\_motion interrupt on X axis

Register 0x19 (INT\_MAP0)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
1	INT1_SIG_STEP	1	1	INT1_STEP	INT1_HD	INT1_RAISE	INT1_SIG_MOT	RW	0xB0

INT1\_SIG\_STEP: 1, map significant step interrupt to INT1 pin  
0, not map significant step interrupt to INT1 pin  
INT1\_STEP: 1, map step valid interrupt to INT1 pin  
0, not map step valid interrupt to INT1 pin  
INT1\_HD: 1, map hand down interrupt to INT1 pin  
0, not map hand down interrupt to INT1 pin  
INT1\_RAISE: 1, map raise hand interrupt to INT1 pin  
0, not map raise hand interrupt to INT1 pin  
INT1\_SIG\_MOT: 1, map significant interrupt to INT1 pin  
0, not map significant interrupt to INT1 pin

Register 0x1a (INT\_MAP1)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
INT1_NO_MOT	1	1	INT1_DATA_A			1	INT1_ANY_MOT	RW	0x62

INT1\_NO\_MOT: 1, map no\_motion interrupt to INT1 pin  
0, not map no\_motion interrupt to INT1 pin  
INT1\_DATA: 1, map data ready interrupt to INT1 pin  
0, not map data ready interrupt to INT1 pin  
INT1\_ANY\_MOT: 1, map any motion interrupt to INT1 pin  
0, not map any motion interrupt to INT1 pin

Register 0x1b (INT\_MAP2)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
1	INT2_SIG_STEP	1	1	INT2_STEP	INT2_HD	INT2_RAISE	INT2_SIG_MOT	RW	0xB0

INT2\_SIG\_STEP: 1, map significant step interrupt to INT2 pin  
0, not map significant step interrupt to INT2 pin  
INT2\_STEP: 1, map step valid interrupt to INT2 pin  
0, not map step valid interrupt to INT2 pin  
INT2\_HD: 1, map hand down interrupt to INT2 pin  
0, not map hand down interrupt to INT2 pin  
INT2\_RAISE: 1, map raise hand interrupt to INT2 pin

INT2\_SIG\_MOT:  
 0, not map raise hand interrupt to INT2 pin  
 1, map significant interrupt to INT2 pin  
 0, not map significant interrupt to INT2 pin

## Register 0x1c (INT\_MAP3)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default	
INT2_NO_MOT	1	1	INT2_DATA	A			1	INT2_ANY_MOT	RW	0x62

INT2\_NO\_MOT: 1, map no\_motion interrupt to INT2 pin  
 0, not map no\_motion interrupt to INT2 pin  
 INT2\_DATA: 1, map register data ready interrupt to INT2 pin  
 0, not map register data ready interrupt to INT2 pin  
 INT2\_ANY\_MOT: 1, map any motion interrupt to INT2 pin  
 0, not map any motion interrupt to INT2 pin

## Register 0x1d (SIG\_STEP\_TH)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
STEP_INTERVAL<7:0>								RW	0x00

STEP\_INTERVAL <7:0>: threshold of significant step. When MOD(STEP\_CNT, STEP\_INTERVAL)=0, SIG\_STEP\_INT will be generated.

## Register 0x1e (raise hand: X\_TH Z\_TH)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
Z_TH<3:0>				X_TH<3:0>				RW	0x66

X\_TH<3:0>: 0~7.5, LSB 0.5 (unit : m/s2)  
 Z\_TH<3:0>: -8~7, LSB 1 (unit : m/s2)

## Register 0x1f

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
STEP_START_CNT<2:0>			STEP_COUNT_PEAK<1:0>		STEP_COUNT_P2P<2:0>			RW	0xA9

STEP\_START\_CNT<2:0>: th\_step\_pattern = 0/4/8/12/16/24/32/40  
 STEP\_COUNT\_PEAK<2:0>: FIXED\_PEAK = 0.05g + 0.05g \* STEP\_COUNT\_PEAK<2:0>. This FIXED\_PEAK is used in algorithm of STEP COUNTER.  
 STEP\_COUNT\_PEAK<2> is in register 0x20<4> and  
 STEP\_COUNT\_PEAK[2:0] = {0x20[4], 0x1F[4:3]}  
 STEP\_COUNT\_P2P<2:0>: FIXED\_P2P = 0.3g + 0.1g \* STEP\_COUNT\_P2P<2:0>. STEP\_COUNT\_P2P[3:0] = {0x1F[2:0]}

## Register 0x20 (INTPIN\_CONF)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
DIS_PU_SE_NB	DIS_IE_ADO	EN_SPI3W	STEP_COU_NT_PEAK<2>	INT2_OD	INT2_LVL	INT1_OD	INT1_LVL	RW	0x05

DIS\_PU\_SENB: 1, disable pull-up resistor of PIN\_SENB  
 0, enable pull-up resistor of PIN\_SENB  
 DIS\_IE\_ADO: 1, disable input of ADO  
 0, not disable input of ADO  
 EN\_SPI3W: 1, enable 3W SPI  
 0, 4W SPI  
 STEP\_COUNT\_PEAK<2>: Definition in 0x1F<4:3>  
 INT2\_OD: 1, open-drain for INT2 pin  
 0, push-pull for INT2 pin  
 INT2\_LVL: 1, logic high as active level for INT2 pin  
 0, logic low as active level for INT2 pin  
 INT1\_OD: 1, open-drain for INT1 pin  
 0, push-pull for INT1 pin  
 INT1\_LVL: 1, logic high as active level for INT1 pin  
 0, logic low as active level for INT1 pin

## Register 0x21 (INT\_CFG)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
INT_RD_CL_R	SHADOW_DIS	DIS_I2C	1	1	1	LATCH_INT_STEP	LATCH_INT	RW	0x1C

INT\_RD\_CLR: 1, clear all the interrupts in latched-mode, when any read operation to any of registers from 0x09 to 0x0D  
 0, clear the related interrupts, only when read the register INT\_ST (0x09 to 0x0D),

no matter the interrupts in latched-mode, or in non-latched-mode.

Reading 0x09 will clear the register 0x09 only and the others keep the status

SHADOW\_DIS: 1, disable the shadowing function for the acceleration data

0, enable the shadowing function for the acceleration data.

When shadowing is enabled, the MSB of the acceleration data is locked, when corresponding LSB of the data is reading.

This can ensure the integrity of the acceleration data during the reading.

The MSB will be unlocked when the MSB is read.

DIS\_I2C: 1: disable I2C. Setting this bit to 1 in SPI mode is recommended  
0: enable I2C

LATCH\_INT\_STEP: 1, step related interrupt is in latch mode  
0, step related interrupt is in non-latch mode

LATCH\_INT: 1, interrupt is in latch mode  
0, interrupt is in non-latch mode

#### Register 0x27 (OS\_CUST\_X)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
OS_CUST_X<7:0>								RW	0x00

OS\_CUST\_X<7:0>: offset calibration of X axis for user, the LSB depends on full-scale of the device which is 3.9mg in 2g range, 7.8mg in 4g range, 15.6mg in 8g range, 31.2mg in 16g, and 62.5mg in 32g

#### Register 0x28 (OS\_CUST\_Y)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
OS_CUST_Y<7:0>								RW	0x00

OS\_CUST\_Y<7:0>: offset calibration of Y axis for user, the LSB depends on full-scale of the device which is 3.9mg in 2g range, 7.8mg in 4g range, 15.6mg in 8g range, 31.2mg in 16g, and 62.5mg in 32g

#### Register 0x29 (OS\_CUST\_Z)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
OS_CUST_Z<7:0>								RW	0x00

OS\_CUST\_Z<7:0>: offset calibration of Z axis for user, the LSB depends on full-scale of the device which is 3.9mg in 2g range, 7.8mg in 4g range, 15.6mg in 8g range, 31.2mg in 16g, and 62.5mg in 32g

#### Register 0x2a (RAISE\_WAKE\_SUM\_TH RAISE\_WAKE\_DIFF\_TH)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
RAISE_WAKE_DIFF_TH<1:0>	RAISE_WAKE_SUM_TH<5:0>							RW	0xD8

RAISE\_WAKE\_SUM\_TH <5:0>: 0 ~ 31.5 (LSB 0.5 m/s<sup>2</sup>)

RAISE_WAKE_DIFF_TH<3:0>	UNIT (m/s <sup>2</sup> )
0	0.2
1	0.3
2	0.4
3	0.5
4	0.6
5	0.7
6	0.8
7	0.9
8	1.0
9	1.1
10	1.2
default	0.2

#### Register 0x2b (RAISE\_WAKE\_DIFF\_TH HD\_X\_TH HD\_Z\_TH)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
HD_Z_TH<2:0>	HD_X_TH<2:0>				RAISE_WAKE_DIFF_TH<3:2>			RW	0x7C

HD\_X\_TH<2:0>: hand down x threshold, 0~7 (m/s<sup>2</sup>)

HD\_Z\_TH<2:0>: hand down z threshold, 0~7 (m/s<sup>2</sup>)

#### Register 0x2c (MOT\_CONFO)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default



Document #: 13-52-12

Title: QMA7981 Datasheet

Rev: C

NO_MOT_DUR<5:0>	ANY_MOT_DUR<1:0>	RW	0x00
NO_MOT_DUR<5:0>:	no motion interrupt will be triggered when slope < NO_MOT_TH for the times which defined by NO_MOT_DUR<5:0> Duration = (NO_MOT_DUR<3:0> + 1) * 1s, if NO_MOT_DUR<5:4> =b00 Duration = (NO_MOT_DUR<3:0> + 4) * 5s, if NO_MOT_DUR<5:4> =b01 Duration = (NO_MOT_DUR<3:0> + 10) * 10s, if NO_MOT_DUR<5:4> =b1x		
ANY_MOT_DUR<1:0>:	any motion interrupt will be triggered when slope > ANY_MOT_TH for (ANY_MOT_DUR<1:0> + 1) samples		
ANY_MOT_DUR<1:0>:			

## Register 0x2d (MOT\_CONF1)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
NO_MOT_TH<7:0>								RW	0x00
NO_MOT_TH<7:0>:	Threshold of no-motion interrupt. The threshold definition is as following TH= NO_MOT_TH<7:0> * 16 * LSB								
ANY_MOT_TH<7:0>:	Threshold of any motion interrupt. The threshold definition is as following TH= ANY_MOT_TH<7:0> * 16 * LSB								

## Register 0x2e (MOT\_CONF2)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
ANY_MOT_TH<7:0>								RW	0x00
ANY_MOT_TH<7:0>:	Threshold of any motion interrupt. The threshold definition is as following TH= ANY_MOT_TH<7:0> * 16 * LSB								
ANY_MOT_TH<7:0>:									

## Register 0x2f (MOT\_CONF3)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
		SIG_MOT_TPROOF<1:0>		SIG_MOT_TSKIP<1:0>			SIG_MOT_SEL	RW	0x00

SIG_MOT_TPROOF<1:0>:	00, T_PROOF=0.25s
	01, T_PROOF=0.5s
	10, T_PROOF=1s
	11, T_PROOF=2s
SIG_MOT_TSKIP<1:0>:	00, T_SKIP=1.5s
	01, T_SKIP=3s
	10, T_SKIP=6s
	11, T_SKIP=12s
SIG_MOT_SEL:	1, select significant motion interrupt
	0, select any motion interrupt

## Register 0x30

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
MO_BP_C_O	STEP_BP_C_O				NO_MOT_RST_N	SIG_MOT_RST_N	ANY_MOT_RST_N	RW	0x1F

MO_BP_CO:	1, motion detector will use data without OS_CUST
	0, motion detector will use data with OS_CUST
STEP_BP_CO:	1, pedometer will use data without OS_CUST
	0, pedometer will use data with OS_CUST

NO\_MOT\_RST\_N : 0, Reset no motion detector. After reset, user should write 1 back.

SIG\_MOT\_RST\_N : 0, Reset significant motion detector. After reset, user should write 1 back.

ANY\_MOT\_RST\_N : 0, Reset any motion detector. After reset, user should write 1 back.

## Register 0x32 (ST)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
SELFTEST_BIT					SELFTEST_SIGN	BP_AXIS_STEP<1:0>		RW	0x00

SELFTEST_BIT:	1, self-test enabled. When self-test enabled, a delay of 3ms is necessary for the value settling. 0, normal
SELFTEST_SIGN:	1, set self-test excitation positive 0, set self-test excitation negative
BP_AXIS_STEP<1:0>:	11, bypass Z axis, use only X and Y axes data for step counter algorithm 10, bypass Y axis, use only X and Z axes data for step counter algorithm 01, bypass X axis, use only Y and Z axes data for step counter algorithm 00, use all of 3 axes data for step counter algorithm

## Register 0x34 (Y\_TH YZ\_TH\_SEL)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
------	------	------	------	------	------	------	------	-----	---------

YZ_TH_SEL<2:0>	Y_TH<4:0>	RW	0x9D
Y TH: -16 ~ 15 (m/s2)			
YZ_TH_SEL<2:0>		UNIT (m/s2)	
0		7.0	
1		7.5	
2		8.0	
3		8.5	
4		9.0	
5		9.5	
6		10.0	
7		10.5	

## Register 0x35 (RAISE\_WAKE\_PERIOD)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
RAISE_WAKE_PERIOD<7:0>								RW	0x81

RAISE\_WAKE\_PERIOD&lt;10:0&gt; \* ODR period = wake count (EX. ODR = 1ms, 0X35 = 100 → wake count = 0.1 sec)

## Register 0x36 (SR)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
SOFT_RESET								RW	0x00

SOFT\_RESET: 0xB6, soft reset all of the registers. After soft-reset, user should write 0x00 back

## Register 0x3e (RAISE\_WAKE\_TIMEOUT\_TH)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
RAISE_WAKE_TIMEOUT_TH<7:0>								RW	0x00

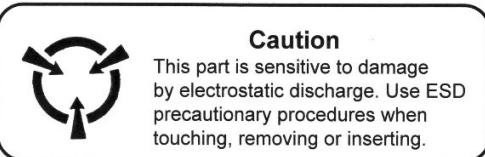
RAISE\_WAKE\_TIMEOUT\_TH&lt;11:0&gt; \* ODR period = timeout count (EX. ODR = 1ms, 0X3e = 100 → timeout count = 0.1 sec)

## Register 0x3f (RAISE\_WAKE\_TIMEOUT\_TH RAISE\_WAKE\_PERIOD RAISE\_WAKE\_EN)

Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	R/W	Default
RAISE_WAKE_PERIOD<10:8>					RAISE_WAKE_TIMEOUT_TH<11:8>				RW 0x02

## ORDERING INFORMATION

Ordering Number	Temperature Range	Package	Packaging
QMA7981-TR	-40°C~85°C	LGA-12	Tape and Reel: 5k pieces/reel

**CAUTION: ESDS CAT. 1B**

## FIND OUT MORE

For more information on QST's Accelerometer Sensors contact us at 86-21-50497300.



**Document #:** 13-52-12

**Title:** QMA7981 Datasheet

**Rev:** C

The application circuits herein constitute typical usage and interface of QST product. QST does not provide warranty or assume liability of customer-designed circuits derived from this description or depiction.

QST reserves the right to make changes to improve reliability, function or design. QST does not assume any liability arising out of the application or use of any product or circuit described herein; neither does it convey any license under its patent rights nor the rights of others.

ISO9001 : 2015

China Patents 201510000399.8, 201510000425.7, 201310426346.3, 201310426677.7, 201310426729.0, 201210585811.3 and 201210553014.7 apply to the technology described.

# X-ON Electronics

Largest Supplier of Electrical and Electronic Components

***Click to view similar products for Accelerometers category:***

***Click to view products by QST manufacturer:***

Other Similar products are found below :

[SX8452QR1](#) [LIS3L02AL](#) [SHUTTLE BOARD BMA222E](#) [832-0050](#) [AD22372Z-RL7](#) [ADXL313WACPZ-RL](#) [MMA1200KEG](#) [1-1001220-0](#)  
[MMA6331LT](#) [FXLN8362QR1](#) [LIS331HHTR](#) [MMA8452QR1](#) [MMA6331LR1](#) [MMA1220KEG](#) [SCA830-D05-1](#) [MXR9150MZ](#)  
[D3965MMA7660FC](#) [BMA423](#) [BMA456](#) [MMA8653FCR1](#) [805M1-0200](#) [ADXL1002BCPZ](#) [834M1-2000](#) [3038-0050](#) [AD22301](#) [805-0500](#)  
[ADXL189BWBRDZUP-RL](#) [3038-0100](#) [ADXL356CEZ](#) [4030-002-120](#) [805M1-0200-01](#) [MXP7205VW](#) [ADXL1001BCPZ](#) [ADXL354BEZ](#)  
[805-0500-01](#) [ADXL357BEZ](#) [3038-0500](#) [MXA2500EL](#) [BU-23842-000](#) [KX126-1063](#) [810M1-0100X](#) [805-0050](#) [ADXL356BEZ](#) [832M1-0025](#)  
[832M1-0500](#) [8101-0040X-120](#) [810M1-0025X](#) [805M1-0020](#) [ADXL700WBRWZ-RL](#) [834M1-6000](#)